Integrated Advanced Microwave Sounding Unit-A (AMSU-A)

Engineering Test Report

METSAT A1 Signal Processor (P/N: 1331670-2, S/N: F03)

Contract No. NAS 5-32314 CDRL 207

Submitted to:

National Aeronautics and Space Administration Goddard Space Flight Center Greenbelt, Maryland 20771

Submitted by:

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1.0 Introduction

This report presents a description of the tests performed, and the test data, for the A1 METSAT Signal Processor Assembly PN: 1331679-2, S/N F03. The assembly was tested in accordance with AE-26754, "METSAT Signal Processor Scan Drive Test and Integration Procedure".

The tests were conducted at room temperature in the AMSU-A test area of building 57. The tests fall into six categories: 1) Continuity, 2) Power Distribution, 3) Digital Processor, 4) Analog Processor, 5) Scan Drive, and 6) Supply Current.

2.0 Objective

The objective is to demonstrate functionality of the signal processor prior to instrument integration.

3.0 Test Data

All test data is presented on the enclosed copies of the test data sheets (TDSs) numbered TDS 1 through TDS 10 (Pages A-2 through A-14). Redlines to the data sheets were necessary and were accomplished in accordance with program directive No. 91. Each change was approved by Quality and the test engineer. Changes were made for the following reasons: 1) Test parameter limits were changed due to design changes in the instrument circuitry, 2) Addition of CCA serial number recording locations, and 3) Correction of a typing error. Also included with the test data sheets is the Manufacturing Assembly Instructions list of the CCA card cage slot assignment record listing each CCA part number and serial number.

4.0 TESTS

4.1 Continuity

A complete continuity test of the backplane wiring is performed at the facility where the wirewrapping of the backplane is done. The continuity tests performed here involve 1) the I/O interface card slots, J301 and J326, 2) the Aerojet added Pre-amp/detector signal cable and connector, 3) the Aerojet added Pre-amp/detector power cable and connector, and 4) chassis return connections. The tests are manual resistance measurements tests. Test data is presented on TDS 1.

4.2 Power Distribution

In these tests supply voltages are input to the signal processor from the Test Relay Unit (TRU) as in normal testing. No CCAs are installed in the signal processor for the tests. The test verifies that the four supply voltages are present on the proper pins of all backplane connectors. The test setup block diagram is shown in Figure 1, and test data is presented on TDS 2.

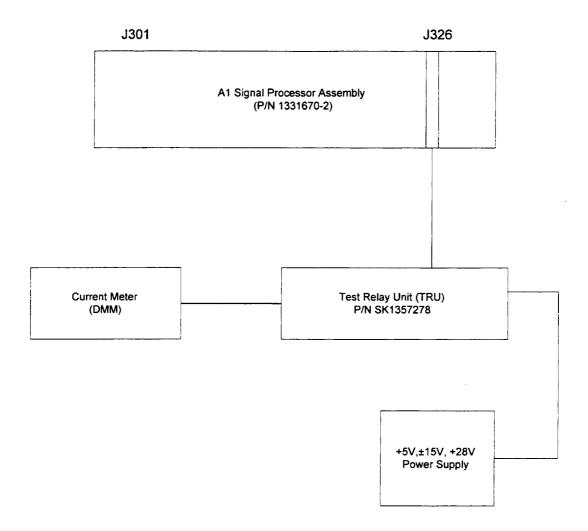


Figure 1. A1 Signal Processor Test Setup

4.3 Digital Processor

Beginning with this test, CCAs are installed into the card cage as required to perform the test, and then remain installed. At the conclusion of all tests, a complete set of CCAs has been installed. The complete test setup block diagram which is required for performing any of the tests is shown in Figure 2.

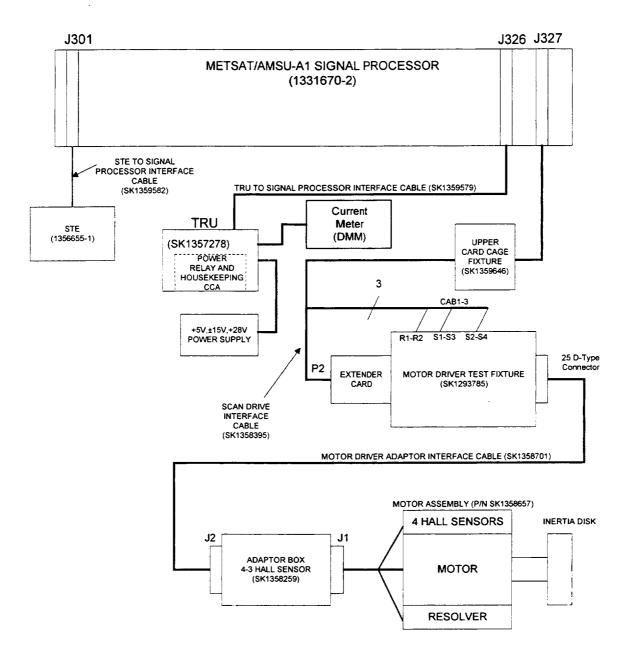


Figure 2 Scan Drive Test Set-Up

4.3.1 Memory

In this test, the digital test set is used in place of the CPU CCA to read and verify data of the test PROMs on the "GOLD" Memory CCA. Test data is presented on TDS 3.

4.3.2 CPU

The CPU test requires that the CPU Auxiliary test CCA be installed in place of the Memory CCA. In this test, the RAM and various instructions performed by the CPU are tested. In addition, the waveform of the clock signal to the DC-DC converter is measured at the CLOCK jack on the TRU. Test data is presented on TDS 3.

4.3.3 Scan Control Interface

In this test, input and output ports 0 through 3 are tested. In addition, the disable feature of the input ports is checked out. Test data is presented on TDS 3.

4.3.4 Timing and Control

In this test, the proper time intervals of I/H, DUMP, INTCMPL, TSCMPL, STOP, and ANTENNA STROBE are verified. In addition to the above tests, the test set also checks the input ports 16 and 17, output port #13 (4 MSBs), output port 14, input port #15 (DAC BSY signal), and output port #13 (4 LSBs). Test data is presented on TDS 3.

4.3.5 Spacecraft Interface

In this test, the STE is turned on and initialized. The STE is tested with a series of self-tests to verify the readiness of the STE to test flight hardware. After successfully passing the self-tests, the STE is used to simulate the spacecraft command signals and retrieve limited test data for the remaining signal processor tests. STE test data is presented on TDS 4.

4.3.6 Relay Control

This test verifies the operation of the module power command and the survival heater command. The presence of the +10 volt Interface power is verified. The PLO lock alarm signals, Scan 1 and 2 relay drive and position indicators, and PLO relay drive and relay position indicators are also verified. Test data is presented on TDS 4.

4.4 Analog Processor

4.4.1 Independence of Measurements

This test is performed using the Analog CCA Test Fixture, the Integrate and Dump Filter and the Analog Mux and A/D Converter CCAs. The test gives a measurement of the sample-to-sample crosstalk within a channel, which is dependent on the completeness of the dump of the integration capacitor. Test data is presented on TDS 5.

4.4.2 Integrate/dump filter, radiometric data multiplexing, and digitization tests

In this test, a 2 volt dc signal is input to each integrate and dump filter, and the channel output code from the A/D converter is measured. The integrator output waveform is also displayed on an oscilloscope for verification of timing. Test data is presented on TDS 6.

4.4.3 Temperature monitoring circuits

In this test a resistor of value approximating the room temperature resistance of the PRTs is connected at the input of each PRT readout circuit, and the output code from the A/D converter is measured. The reference voltage used in the PRT readout circuits is also measured. Test data is presented on TDS 7.

4.4.4 Analog telemetry

In this test each of the analog telemetry signals is measured at the ANALOG HSKP jack on the TRU. Test data is presented on TDS 8.

4.5 Scan Drive

This test includes all CCAs involved in the scan drive function. The circuitry is programmed to provide one complete revolution of the drive motor as it steps through each of the thirty scene positions and the two calibration positions. The circuitry is programmed to park at the Warm Cal, Cold Cal, and the Nadir positions during the test sequence. The GSE test modes are also verified. To verify proper performance, the inertia disk on the motor shaft is visually observed through the one revolution and the various calibration positions. Test data is presented on TDS 9.

4.6 Supply Current

In this test, the total current drawn by the signal processor from each of the four supply voltages is measured with the signal processor fully populated with CCA's. Test data is presented on TDS 10.

5.0 TEST ANOMALIES

No test anomalies occurred during the Signal Processor engineering tests.

6.0 TEST RESULTS

The METSAT/AMSU A1 SIGNAL PROCESSOR TEST was successfully completed and all test data is within specified limits.

F03

GENCORP	MANUFACTURING ASSEMBLY INSTRUCTIONS (M.A.I.)						PAGE	OF
AEROJET	PART DESCRIPTION SIGNAL PROCESSING ASSY. PART NUMBER 1331670-2						6	7
J. DIPASQUALE		5/08/97	REVISION 01	NEXT ASSEMBLY	1331720-2		00!	



Record Serial Numbers of each CCA below.

- d) Record S/N of each CCA in the area noted below, also record S/N on the Data Sheet.
 Note: CCA'S will be installed at Operation 0120 per AE-26002/3 Test Procedure.
- e) Record Part No. and S/N of CCA required, for location J317 Connector.

LOCATION	ITEM#	CCA PART NO.	SERIAL NO.	DESCRIPTION	COMMENTS
J301					
J302					
J303	2	1338421-1	F19	TEMP. SENSOR A	
J304	3	1331682-1	F289	TEMP. SENSOR BD. "B"	
J305	3	1331682-1	F32	TEMP. SENSOR BD. "B"	
J306	4	1331688-1	F16	Temp.Sensor,ANLG MUX	
J307	5	1356418-1	F04	MUX AND ANLG/DGTL	
J308	6	1338424-1	F16	INTEG. & DUMP FILTER	
J309	6	1338424-1	F19	INTEG. & DUMP FILTER	
J310	6	1338424-1	F27	INTEG. & DUMP FILTER	
J311	6	1338424-1	F37	INTEG. & DUMP FILTER	
J312	7	1331147-1	F19	SPACECRAFT I/F NO.2	
J313	8	1331144-1	F19	SPACECRAFT I/F NO.1	
J314	9	1351150-1	F22	PARALLEL TO SER CNVTR	
J315	10	1331135-1	FII	TIMING AN CONTROL	
J316	11	1356413-2	FOZ	CPU	
J317	12	*1331126-1(Fol	MEMORY ASSY.	**
J318	13	1331129-1	F16	SCAN CONTROL INTFC	
J319	40	1356911-1	FOI	RELAY DRVR & CUR MO	N
J320	14	1331697-1	F27	Interface/Converter	***
J321	15	1334972-1	F21	RSLVR DATA ISOL	
J322	16	1337739-1	Faa	R-D CONVERTER/OSC	***
J323	14	1331697-1	F34	Interface/Converter	***
J324	15	1334972-1	F31	RSLVR DATA ISOL	
J325	16	1337739-1	F25	R-D CONVERTER/OSC	***
J326					
J327					

^{* =} See table #1 for selection of CCA required at this location.

670dasht1

*** = Test and select resistors added at system level test.

Not Conformal Coated when installed at next assembly.

Figure #4

^{** =} Memory CCA installed at next assembly.

TEST DATA SHEET 1 A1 Continuity Tests (4.2.1)

From	То	Signal Name	Pass/Fail
J301-1	P511-3	CH 3 - IN	P
J301-10	P511-13	CH 8 - IN	P
J301-13	P511-15	CH 9 - IN	P
J301-15	P511-17	CH 10 - IN	P
J301-16	P511-19	CH 11 - IN	P
J301-19	P511-21	CH 12 - IN	כן
J301-21	P511-23	CH 13 - IN	حر
J301-22	P511-25	CH 14 - IN	P
J301-25	P511-1	CH 15 - IN	P
J301-3	P511-5	CH 4 - IN	P
J301-4	P511-7	CH 5 - IN	P
J301-60	E1	CHASSIS GND	P
J301-7	P511-9	CH 6 - IN	P
J301-9	P511-11	CH 7 - IN	ρ
J301-90	E2	CHASSIS GND	م
J304-43	P512-5	+15V(2)	P
J304-45	P512-24	+15V(2)	ρ
J304-46	P512-9	15VRTN(2/3)	P
J304-48	P512-29	15VRTN(2/3)	P
J304-49	P512-14	-15V(3)	19
J304-51	P512-15	-15V(3)	P
J305-68	P512-12	PRT35_HI (PRE AMP)	P
J305-72	P512-11	PRT35_LO (PRE AMP)	P
J326-76	E3	CHASSIS GND	12

Assembly No. 1331670 - 2	Shop Order No. <u>543651</u>
Serial No. F03	Pass Fail
Test Engineer Oscil 10/20/98 (Signature (Date)	Quality Control (Signature) (Date) 98
Customer Representative (Flight hardware only) (Signature	(Date)

TEST DATA SHEET 2 Al Power Distribution (Paragraphs 4.2.2 & 4.2.3)

Power Supply Voltages: + 5.7 ± 0.1V: 5.672V +15.7 ± 0.1V: 15, 6.83 V											
	15.7 ± 0.1 V:	75.6	940	<u>, </u>	+2	8.7 ± 0.1 V:	2	8.75V	···-		
Test Set-i	Test Set-up Verified: YES NO										
Para.	Connector	+5 ±0.5 V	P/F	+15 ±0.3V	P/F	-15 ±0.3V	P/F	+28 ±0.56V	P/F	+9 ±1V*	P/F
4.2.3 Step	No.	±0.5 ¥		20.54							
No.							mmana	anninimininimini	minama		
7*	J301									9.4	P
1	J303			14.98	P	-15.01	12				
2	J304			14.98	P	-15,00	P				
3	J305			14.98		-15,00					
4	J306			14.98	P	-15.00					
5	J307	4.95	حر	14.98	P	-15.00					
5	J308			14.98	P	-15.00	P				
5	J309			14.98	P	-15.00					
5	J310			14.98	P	-15,00					
5	J311			14.98	P	-15.00	P			0 1	12
5	J312	4.95	P							9.4	10
5	J313	4.95	12							9.4	
5	J314	4.95	12								
5	J315	4.95	12								
5	J316	4.95	10								
5	J317	4.95	P								
5	J318	4.95	12								
5	J319	4.95	P	14.98	P	-15.01	P	28,05	1		
5	J320	4.96	P	14.98	P	-15.01					
5	J321	4.96	P				13				
5	J322	4.96	P	14.98	P	-15,00					
5	J323	4.96	P	14.98	12	-15.01	12				
5	J324	4.96	P			_					
5	J325	4.96	P	14.98	P	-15.01	12	2.64 =6	C		
6	J327	4.96	P	14.98	P	-15.01	P	28.09	1		
	ed at paragraph		M		_		 _	42/	/		
Assembly	y No/33	1670-	- 1		Sh	op Order No	5 '	T763	<u>'</u>		
Serial No. 1-03 Pass Fail											
Test Eng	. 0	Lud	10,	120/98	- Qı	uality Contro		16 Hiller	aua	0CT 21 98	
	(Signature (Date)										
Custome	Customer Representative (Flight hardware only)										
				/ (Sign	iature)/		(D	ate)			
1											

TEST DATA SHEET 3 (Sheet 1 of 2) A1 Digital Processor (Paragraph 4.2.4)

					· · · · · · · · · · · · · · · · · · ·			
CPU CC Scan Con	CA Serial No. (J31) ntrol Interface CC	6) <u> </u>	16		•			
Timing and Control CCA Serial No. (J315)								
4.2.4.1 Memory tests	s:							
4.2.4.1/10 Circle Pass	or Fail to indicate	e the result of the tests:		Pass	Fail			
If "F	Fail", record the er	tror code and error descrip	ption.					
	Error Code:	_ N/A						
	Error Description	on: NA						
4.2.4.2 CPU tests:								
4.2.4.2/10		Measurements	<u>Limits</u>		Pass/Fail			
4.2.4.2/10	V	3.80 Vpp	3.30 - 4.94 V		P			
	Vp-p	8012S			P			
	Т	00133	761 - 841 ns					
					P			
4.2.4.2/19 Circle	Pass or Fail to ind	licate the result of the CP	U tests		Pass Fail			
	m							
4.2.4.3 Scan Control					_			
4.2.4.3/16 The input p	orts 0 and 1 tests			Pass	Fail			
4.2.4.3/23 Inhibit inpu	it port 0 and 1 test	s		Pass	Fail			
4.2.4.3/35 The input p				Pass	Fail			
4.2.4.3/48 Inhibit inpu	it port 2 and 3 test	s		Pass	Fail			
4.2.4.3/55 The output	ports 0 and 1 tests	3		Pass	Fail			

TEST DATA SHEET 3 (Sheet 2 of 2) A1 Digital Processor (Paragraph 4.2.4)

4.2.4.3 Scan	Control Interface Tests (Cont):
4.2.4.3/63 Th	e output ports 2 and 3 tests Pass Fail
	If "Fail", record the error code and error description.
	Error Code:
	Error Description:
4.2.4.4 Timir	ng and Control Tests:
4.2.4.4/13	The Integrate and Hold pulse and the Dump pulse at the card rack slot J308. Pass Fail
4.2.4.4/23	The Integrate and Hold pulse and the Dump pulse at the card rack slot J309. Fail
4.2.4.4/33	The Integrate and Hold pulse and the Dump pulse at the card rack slot J310. Pass Fail
4.2.4.4/43	The Integrate and Hold pulse and the Dump pulse at the card rack slot J311. Pass Fail
4.2.4.4/54	The Integrate and Hold pulse and the Dump pulse at the card rack slot J301. Pass Fail
4.2.4.4/64	The Antenna Strobe pulse test at J320. Pass Fail
4.2.4.4/68	The Antenna Strobe pulse test at J323. Pass Fail
4.2.4.4/78	The test of the interface to the Temp. Sensor Analog Mux card rack slot J306. Pass Fail
4.2.4.4/89	The test of the interface to the Analog Mux and Converter card rack slot Pass Fail J307.
	If "Fail", record error code and error description:
	Error Code:
	Error Description:
Assembly No.	133/670-2 Shop Order No. 54365-1
Serial No	F03 Pass Fail
Test Engineer	(Signature (Date) Quality Control (Signature) (Date)
Customer Repr	resentative (Flight hardware only) (Signature) (Date)

TEST DATA SHEET 4 Al Relay Driver Tests (Paragraph 4.2.5.2)

Spaced Spaced Paralle Relay	rraft Interface #2 C traft Interface #1 C I to Serial Conver Driver And Currer	CCA (J312) Ser. NoF/9 CCA (J313) Ser. NoF/9 ter CCA (J314) Ser. NoF 22 at Monitor CCA (J319) Ser. NoF0/	- - -				
Test Se	et-up Verified:	Yes No	STE Self Test: Pass Fail				
	Step No.	Test Description	Pass/Fail				
	23	Module power connects	P				
	26	Survival heater power turns on	P				
	27	Survival heater power turns off	P				
	28	Module power disconnects	P				
	30	Scanner 1 power turns on	P				
	31	Scanner 2 power turns on	P				
	32	Scanner 1 power turns off	P				
:	32	Scanner 2 power turns off	P				
	34	PLLO toggle	P				
	35	Module power disconnect	P				
Assembly No							

TEST DATA SHEET 5 A1 Independence Of Measurements (Paragraph 4.2.6.1)

Test Set-up verifi	ed: YES	NO			
Supply		Measured Value (V)	<u>Lim</u>	its (V)	
+5		4.806V	+5 ±	- 0.25	
+15		15.892	+15	± 1.0	
-15		-15.42V	-15 :	± 1.0	
Integrate and Dump/Filter CCA Serial No.	Channel No.	Average for SIGNAL switch in HI position	Average for SIGNAL switch in LO position	Measurement Dependence ≤0.01%	Pass/ Fail
	0	14171.3	14169.6	0.00259	P
F16	1	14168.9	14165.9	0.00458	<i>P</i>
	2	14176.6	14174.8	0.00275	P
	3	14174	14171.9	0.0032	P
	0	14155.9	14154.8	0.00168	P
	1	14143	14141.8	0.00183	Ρ
F19	2	14154.9	14152.9	0.00305	P
	3	14162.7	14160.7	0.00305	P
	0	14105.6	14103.7	0.0029	P
/ - 7	1	14106.9	14105	0.0029	P
F27	2	14095.9	14092.8	0,00473	P
	3	14/20,9	14/19	0.0029	P
	0	14181.7	14179	0.00412	Ρ
	1	14175.7	14173.7	0.00305	P
F37	2	14170	14167.6	0.00366	P
	3	14178.8	14176.8	0.00305	P
ibly No. <u>/33</u> No. <u>F03</u>		Sho	op Order No. 5	43651	
ngin ce (Signatur	papela	10/20/98 Qua	ality Control(Sign	nature)	(Dale)

TEST DATA SHEET 6 (Sheet 1 Of 2) A1 Integrator Signal Multiplexing, And Digitization (Paragraph 4.2.6.2)

V1 Output Waveform	V2 -25 ±2 ms -
	190 ±9.5 ms

Channel	Data	Data Limits	Data Pass/Fail	Integrator Waveform Pass/Fail
3	29265	27282 to 31076	P	12
4	29241	27282 to 31076	P	P
5	29114	27282 to 31076	P	P
6	29213	27282 to 31076	P	P
7	29218	27282 to 31076	P	P
8	29/84	27282 to 31076	P	P
9	29007	27282 to 31076	P	P
10	29267	27282 to 31076	حر	P
- 11	19233	27282 to 31076	P	P
12	29240	27282 to 31076	P	P
13	29109	27282 to 31076	P	P
14	29280	27282 to 31076	P	P
15	29256	27282 to 31076	P	P

TEST DATA SHEET 6 (Sheet 2 Of 2) A1 Integrator Signal Multiplexing, And Digitization (Paragraph 4.2.6.2)

Signal Name	Output	Output Return	Signal Levels	- Pass/Fail
I/H	J301-42	J301-41	Pulses (TTL)	P
Dump	J301-45	J301-41	Pulses (TTL)	P
+5 Vdc GSE Interlock A	J301-61	J301-70	+5 V	P
+5 Vdc GSE Interlock B	J301-62	J301-70	+5 V	P

Assembly No. 133/670-2	Shop Order No. <u>543657</u>
Serial No. Fo3	Pass Fail
Test Engineer Oscillator (Date) (Signature (Date)	Quality Control (Signature) (Date) (Date) (Date)
Customer Representative (Flight hardware only) (Signature	(Date)

TEST DATA SHEET 7 (Sheet 1 of 2) Al Temperature Monitoring Circuits (Paragraph 4.2.6.3)

Temperature Sensor A CCA(J303) Serial No. F19
Temperature Sensor B CCA (J304) Serial No. F29
Temperature Sensor B CCA (J305) Serial No. F32
Temperature Sensor Analog Mux CCA (J306) Serial No. F16

Dig. A Temp No.	Description	Data	Data Limits	Pass/Fail
	<u> </u>			
<u> </u>	Scan Motor A1-1	3/3/0	28259 to 32513	P
22	Scan Motor A1-2	3/4/5	28259 to 32513	P
3	Feedhorn A1-1	30499	28259 to 32513	P
4	Feedhorn A1-2	31296	28259 to 32513	P
5	RF MUX A1-1	3/275	28259 to 32513	P
6	RF MUX A1-2	3/375	28259 to 32513	P
7	LO CH 3	31520	28259 to 32513	P
8	LO CH 4	3/367	28259 to 32513	P
9	LO CH 5	3/6/5	28259 to 32513	P
10	LO CH 6	3/345	28259 to 32513	P
11	LO CH 7	3/398	28259 to 32513	P
12	LO CH 8	3/158	28259 to 32513	P
13	LO CH 15	3/375	28259 to 32513	P
14	PLO #2	3/344	28259 to 32513	P
15	PLO #1	31416	28259 to 32513	P
16	N/A	N/A	N/A	N/A
17	Mixer IF CH 3	31446	28259 to 32513	P
18	Mixer IF CH 4	31082	28259 to 32513	P
19	Mixer IF CH 5	3/3/7	28259 to 32513	P
20	Mixer IF CH 6	3/208	28259 to 32513	P
21	Mixer IF CH 7	3/359	28259 to 32513	P
22	Mixer IF CH 8	31282	28259 to 32513	P
23	Mixer IF CH 9/14	3/650	28259 to 32513	P
24	Mixer IF CH 15	3/24/	28259 to 32513	P
25	IF Amp CH 11/14	3/3//	28259 to 32513	P
26	IF Amp CH 9	31398	28259 to 32513	P
27	IF Amp CH 10	3/435	28259 to 32513	P
28	IF Amp CH 11	3/55/	28259 to 32513	P
29	DC/DC Conv	3//85	28259 to 32513	P
30	IF Amp CH 13	3/386	28259 to 32513	P
31	IF Amp CH 14	3/38-3	28259 to 32513	כן
32	IF Amp CH 12	3/583	28259 to 32513	P
33	RF Shelf A1-1	3/190	28259 to 32513	P
34	RF Shelf A1-2	28387	28259 to 32513	P
35	Detector/Preamp	3/295	28259 to 32513	P

TEST DATA SHEET 7 (Sheet 2 of 2) Al Temperature Monitoring Circuits (Paragraph 4.2.6.3)

Dig. A Temp No.	Description	Data	Data Limits	Pass/Fail
36	A1-1 Warm Load 1	22552	20339 to 23401	P
37	A1-1 Warm Load 2	117/9	20339 to 23401	P
38	A1-1 Warm Load 3	22751	20339 to 23401	P
39	A1-1 Warm Load 4	2283/	20339 to 23401	P
40	A1-1 Warm Load C	227/1	20339 to 23401	P
41	A1-2 Warm Load 1	22587	20339 to 23401	P
42	A1-2 Warm Load 2	22687	20339 to 23401	P
43	A1-2 Warm Load 3	12886	20339 to 23401	P
44	A1-2 Warm Load 4	22440	20339 to 23401	P
45	A1-2 Warm Load C	22739	20339 to 23401	P
46	Thermal Reference	25402	23340 to 26320	P

TEST DATA SHEET 8 Al Analog Telemetry (Paragraph 4.2.6.4)

ANALOG HSKP Switch Position	DVM Reading (V)	Limits (V)	Pass/Fail
1	2.98	2.85 to 3.15	P
2	3.453	3.30 to 3.66	P
3	2.968	2.87 to 3.17	P
4	3.001	2.85 to 3.15	Р
5	3.452	3.30 to 3.66	P
6	2.982	2.87 to 3.17	ρ
7	3.449	3.30 to 3.66	Ρ
8	2.976	2.87 to 3.17	Р
9	2.979	2.85 to 3.15	Ρ
10	3.569	3.42 to 3.78	P
11	3.263	3.13 to 3.45	P
12	2.963	2.84 to 3.14	Р
13	2.953	2.84 to 3.14	P
14	2.961	2.84 to 3.14	P
15	2.967	2.84 to 3.14	P
16	2.970	2.84 to 3.14	ρ
17	2.966	2.84 to 3.14	P
18	3.447	3.30 to 3.66	P
19	0.05	4.30 to 4.66 -0.1 to	P
19	-4.035	0.4 to 0.48 -3.7 to -4.3	Р
20	0.059	4.30 to 4.66 - 0.1 to	P
20	-4.025	0.4 to 0.48 -3.7 ±0	Р
21	0.006	-0.05 to 0.05	P
21	2.963	2.8 to 3.4	Р
22	0.017	-0.05 to 0.05	ρ
22	2.970	2.8 to 3.4	P

Assembly No. 133/670-2 Shop Order No. 54365

Serial No. Fo 3 Pass Fail Quality Control (Signature) (Date)

Customer Representative (Flight hardware only) (Signature) (Date) (Date)

TEST DATA SHEET 9 A1 Scan Drive/ Signal Processor Tests (Paragraph 4.3.1 And 4.3.2)

A1-1 D	rive Subsystem CC	As:				
Resolve	er Data Isolator CC	J320) Ser. No	19 ad 98			
1030 50	t-ap vermee.		(229)			
	Para/Step No.	Mode	Pass/Fail			
	4.3.1.2.1/11	Motor in warm cal position	P			
	4.3.1.2.2/3	Motor in nadir position				
	4.3.1.2.3/2	Motor in cold cal position 1	P			
	4.3.1.2.3/3	Motor in cold cal position 2	P			
	4.3.1.2.3/4	Motor in cold cal position 3	P			
	4.3.1.2.3/5	Motor in cold cal position 4	Ρ			
	4.3.1.2.4/5	Motor in full scan mode	P			
	4.3.1.2.5/9	GSE mode 2	P			
	4.3.1.2.6/4	GSE mode 4	P			
	4.3.1.2.7/4	GSE mode 5	ρ			
	4.3.1.2.8/4	GSE mode 1	P			
	4.3.1.2.9/4	GSE mode 3	Ρ			
	4.3.1.2.9/7	GSE mode 7	P			
	4.3.1.2.10/2	Scan power off	P			
Interfa Resolv R/D Co Motor Test Se	er Data Isolator CC	(J323) Ser. No	19 Sand 9/20/08 QC 229			
4.3.2.2 A1-2 scan drive operates in full scan mode. Pass Fail						
Assembly No. 133/670-2 Shop Order No. 54365						
Serial	No. <u> </u>	Pass Fail	_			
Test Engineer Oly Quality Control (Signature (Date) (Date) (Signature (Date) (D						
		(Signature) (Date)				

TEST DATA SHEET 10 Al Supply Currents (Paragraph 4.4)

Voltages	Measured Current	Limits (in mA)	Pass/Fail	
+28.7V	7.55	6 to 12	P	
+5.7V	660	700 to 1642 550 to 900	P	
+15.7V	197	152 to 364	P	
-15.7V	192	162 to 381	P	

1020

Assembly No. 133/670-2 Shop Order No. 54365/

Serial No. Fo3 Pass Fail

Test Engineer Order No. 54365/

(Signature (Date) Quality Control (Signature) (Date)

Customer Representative (Flight hardware only) (Signature) (Date)

(Signature) (Date)

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National Aeronautics and Space Administration Report Documentation Page						
1. Report No. 2	Government Accession N	о.	3. Recipient's Catalog N	No.		
A. Title and Subtitle Integrated Advanced Microwave Sounding Unit (AMSU-A), Engineering Test Report		Init-A	5. Report Date 28 Octob 6. Performing Organizati			
(Alvido-A), Engineering 1	Cot (Cport					
7. Author(s) D. Lund			8. Performing Organizati 11302 10. Work Unit No.	ion Report No.		
9. Performing Organization Name and Address Aerojet 1100 W. Hollyvale Azusa, CA 91702			11. Contract or Grant No. NAS 5-32314 13. Type of Report and Period Covered			
12. Sponsoring Agency Name and Address NASA Goddard Space Flight Center			Final 14. Sponsoring Agency			
Greenbelt, N	Maryland 20771		*			
16. ABSTRACT (Maximum 200 words)						
This is the Engineering Test Report, METSAT A1 Signal Processor (P/N 1331670-2, S/N F03), for the Integrated Advanced Microwave Sounding Unit-A (AMSU-A).						
17. Key Words (Suggested by Author(s))	18. Distribution	Statement			
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